

XC4000X Series High-Reliability Field Programmable Gate Arrays

November 12, 1997 (Version 1.0)

XC4000X Series Features

- Available in military temperature range (-55 °C to 125 °C, T_C)
- XC4036XL and XC4062XL available in -3 speed
- XC4028EX available in -4 speed
- System featured Field-Programmable Gate Arrays
 - Select-RAM™ memory: on-chip ultra-fast RAM with
 - synchronous write option
 - dual-port RAM option
 - Abundant flip-flops
 - Flexible function generators
 - Dedicated high-speed carry logic
 - Wide edge decoders on each edge
 - Hierarchy of interconnect lines
 - Internal 3-state bus capability
 - 8 global low-skew clock or signal distribution networks
- System Performance beyond 50 MHz
- Flexible Array Architecture
- Low Power Segmented Routing Architecture
- Systems-Oriented Features
 - IEEE 1149.1-compatible boundary scan logic support
 - Individually programmable output slew rate
 - Programmable input pull-up or pull-down resistors
 - 12-mA Sink Current Per XC4000X Output
- Configured by Loading Binary File
 - Unlimited reprogrammability
- Readback Capability
 - Program verification
 - Internal node observability
- Development System runs on most common computer platforms
 - Interfaces to popular design environments
 - Fully automatic mapping, placement and routing
 - Interactive design editor for design optimization
 - Highest Capacity Over 130,000 Usable Gates
- Additional Routing Over XC4000E
 - almost twice the routing capacity for high-density designs
- Buffered Interconnect for Maximum Speed
- New Latch Capability in Configurable Logic Blocks
- Improved VersaRing[™] I/O Interconnect for Better Fixed Pinout Flexibility
 - Virtually unlimited number of clock signals
- Optional Multiplexer or 2-input Function Generator on Device Outputs

Advance Product Specification

Low-Voltage Versions Available

- Low-Voltage Devices Function at 3.0 3.6 Volts
- XC4000XL: High Performance Low-Voltage Versions of XC4000EX devices
- 5V tolerant I/Os on XC4000XL
- 0.35µ SRAM process for XC4000XL

Introduction

XC4000X Series high-performance, high-capacity Field Programmable Gate Arrays (FPGAs) provide the benefits of custom CMOS VLSI, while avoiding the initial cost, long development cycle, and inherent risk of a conventional masked gate array.

The result of thirteen years of FPGA design experience and feedback from thousands of customers, these FPGAs combine architectural versatility, on-chip Select-RAM memory with edge-triggered and dual-port modes, increased speed, abundant routing resources, and new, sophisticated software to achieve fully automated implementation of complex, high-density, high-performance designs.

Refer to the complete Commercial XC4000E and XC4000X Series Field Programmable Gate Arrays Data Sheet for more information on device architecture and timing.

Device	Logic Cells	Max Logic Gates (No RAM)	Max. RAM Bits (No Logic)	Typical Gate Range (Logic and RAM)*	CLB Matrix	Total CLBs	Number of Flip-Flops	Max. User I/O	Packages
XC4028EX	2432	28,000	32,768	18,000 - 50,000	32 x 32	1,024	2,560	256	PG299, CB228
XC4036XL	3078	36,000	41,472	22,000 - 65,000	36 x 36	1,296	3,168	288	PG411, CB228
XC4062XL	5472	62,000	73,728	40,000 - 130,000	48 x 48	2,304	5,376	384	PG475, CB228

Table 1:	XC4000X Se	ries Hiah I	Reliability	Field Pro	grammable	Gate Arravs
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* Max values of Typical Gate Range include 20-30% of CLBs used as RAM.

Ordering Information

